

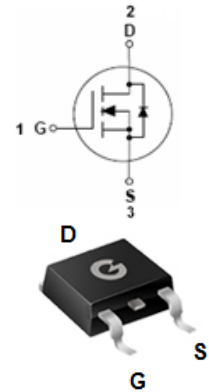
Features

- Low $R_{DS(ON)}$ & FOM
- Extremely low switching loss
- Excellent stability and uniformity
- Halogen free
- Qualified to AEC-Q101 standards for high reliability

HF

Mechanical Data

- Case: TO-252
- Molding Compound: UL Flammability Classification Rating 94V-0
- Terminals: Matte tin-plated leads; solderability-per MIL-STD-202, Method 208



TO-252

Ordering Information

Part Number	Package	Shipping Quantity	Marking Code
TBL170N10TD	TO-252	80 pcs / Tube & 2500 pcs / Tape & Reel	170N10TD

Maximum Ratings (@ $T_C = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-to-Source Voltage	V_{DS}	100	V
Gate-to-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current ($T_C = 25^\circ\text{C}$) *5	I_D	50	A
Continuous Drain Current ($T_C = 100^\circ\text{C}$) *5	I_D	32	A
Continuous Drain Current ($T_A = 25^\circ\text{C}$)	I_D	8	A
Continuous Drain Current ($T_A = 100^\circ\text{C}$)	I_D	5	A
Pulsed Drain Current *3	I_{DM}	180	A
Single Pulse Avalanche Energy *3, 6	E_{AS}	11	mJ

Thermal Characteristics

Parameter	Symbol	Value	Unit
Power Dissipation ($T_C = 25^\circ\text{C}$) *2	P_D	83	W
Thermal Resistance Junction-to-Air *1, 4	$R_{\theta JA}$	55	$^\circ\text{C/W}$
Thermal Resistance Junction-to-Case	$R_{\theta JC}$	1.5	$^\circ\text{C/W}$
Operating Junction Temperature Range	T_J	$-55 \sim +150$	$^\circ\text{C}$
Storage Temperature Range	T_{STG}	$-55 \sim +150$	$^\circ\text{C}$

Electrical Characteristics (@ $T_c = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Unit
Static Characteristics						
V _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0V, I _D = 250μA	100	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 80V, V _{GS} = 0V	-	-	1	μA
I _{GSS}	Gate-Body Leakage Current	V _{GS} = ±20V, V _{DS} = 0V	-	-	±100	nA
R _{DS(ON)}	Static Drain-Source On-resistance	V _{GS} = 10V, I _D = 20A	-	14	17	mΩ
		V _{GS} = 4.5V, I _D = 10A	-	19	25	mΩ
V _{GS(th)}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 250μA	1.2	1.8	2.5	V
R _G	Gate Resistance	V _{DS} = V _{GS} =0V, f=1MHz	-	2.7	-	Ω
Dynamic Characteristics						
C _{ISS}	Input Capacitance	V _{GS} = 0V V _{DS} = 25V f = 1.0MHz	-	1102	-	pF
C _{OSS}	Output Capacitance		-	537	-	
C _{RSS}	Reverse Transfer Capacitance		-	39	-	
Q _G	Total Gate-Charge	V _{DS} = 80V V _{GS} = 10V I _D = 15A	-	25	-	nC
Q _{GS}	Gate to Source Charge		-	6.4	-	
Q _{GD}	Gate to Drain (Miller) Charge		-	5.6	-	
Switching Characteristics						
t _{d(ON)}	Turn-on Delay Time	V _{DS} = 50V V _{GS} = 10V R _G = 3.3Ω I _D = 40A	-	44	-	ns
t _r	Turn-on Rise Time		-	51	-	
t _{d(OFF)}	Turn-Off Delay Time		-	253	-	
t _f	Turn-Off Fall Time		-	112	-	
Source-Drain Diode Characteristics						
V _{SD}	Diode Forward Voltage	I _{SD} = 15A, V _{GS} = 0V	-	0.88	1.0	V
t _{rr}	Reverse Recovery Time	I _{SD} = 15A, V _R =30V dI _{SD} /d _t = 100A/μs	-	45	-	ns
Q _{rr}	Reverse Recovery Charge		-	50	-	nC

Notes:

- The value of $R_{\theta JC}$ is measured in a still air environment with $T_A = 25^\circ\text{C}$ and the maximum allowed junction temperature of 150°C . The value in any given application depends on the user's specific board design
- The power dissipation P_D is based on $T_{J(MAX)} = 150^\circ\text{C}$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used
- Single pulse width limited by junction temperature $T_{J(MAX)} = 150^\circ\text{C}$
- The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case $R_{\theta JC}$ and case to ambient
- The maximum current rating is package limited
- The E_{AS} data shows Max. rating. The test condition is $V_{DS} = 50V, V_{GS} = 10V, L = 0.5mH, I_{AS} = 6A$

Ratings and Characteristics Curves (@ $T_A = 25^\circ\text{C}$ unless otherwise specified)

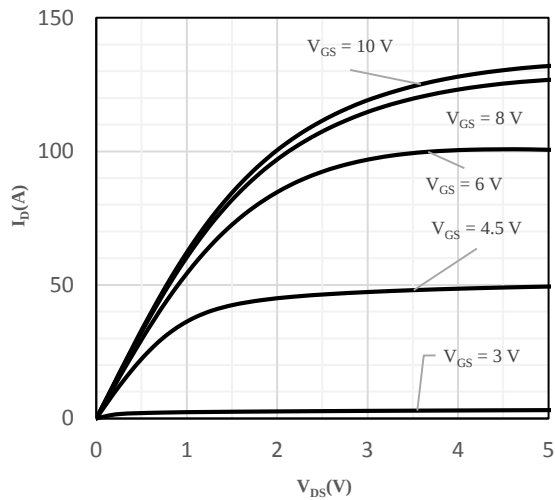


Fig 1 Typical Output Characteristics

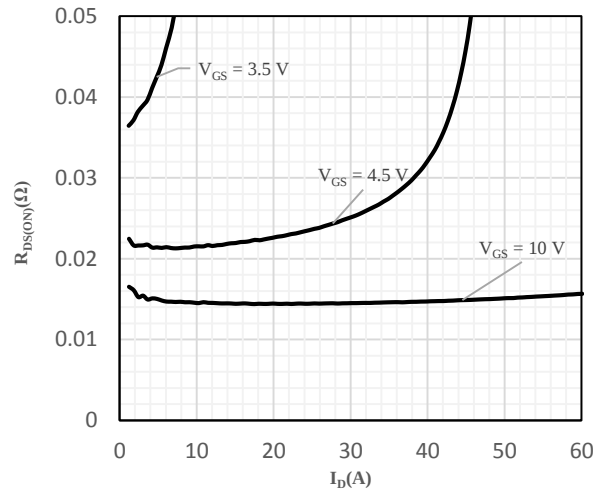


Fig 2 On-Resistance vs. Drain Current

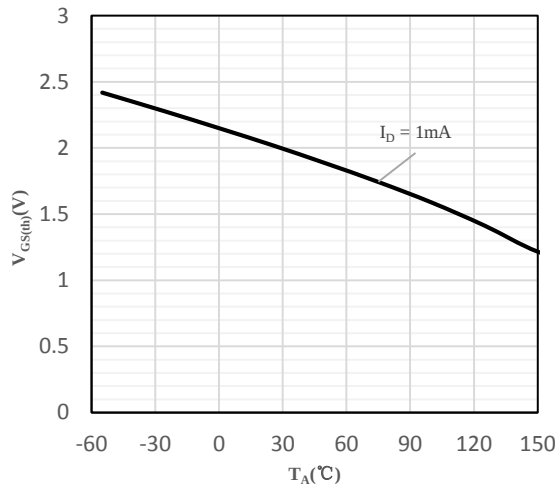


Fig 3 Gate Threshold Voltage vs.
Junction Temperature

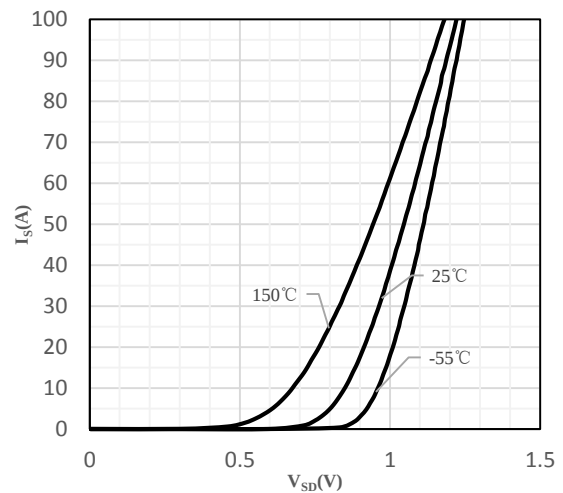


Fig 4 Body-Diode Characteristics

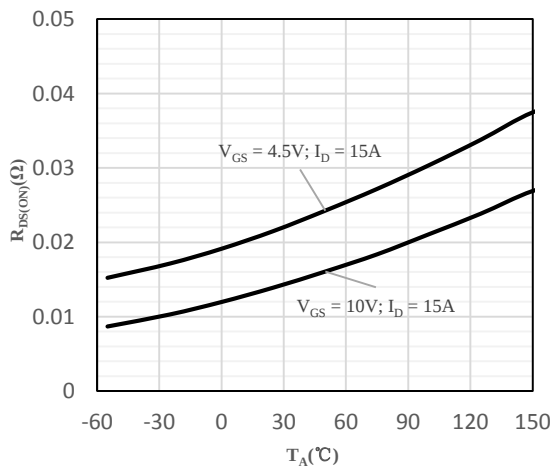


Fig 5 On-Resistance vs. Junction Temperature

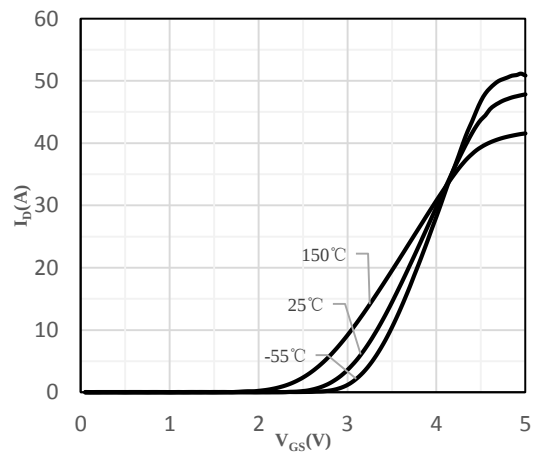


Fig 6 Transfer Characteristics

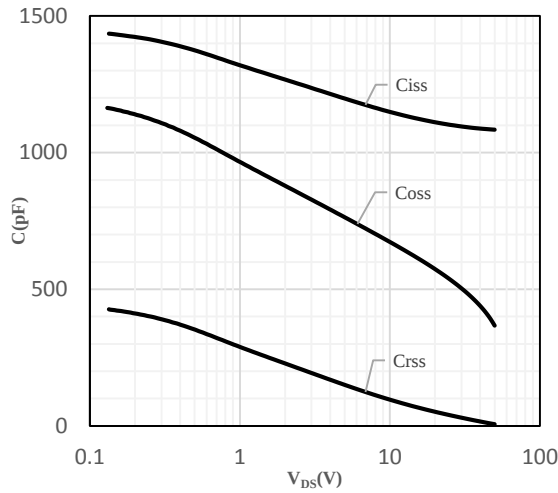


Fig 7 Capacitance Characteristics

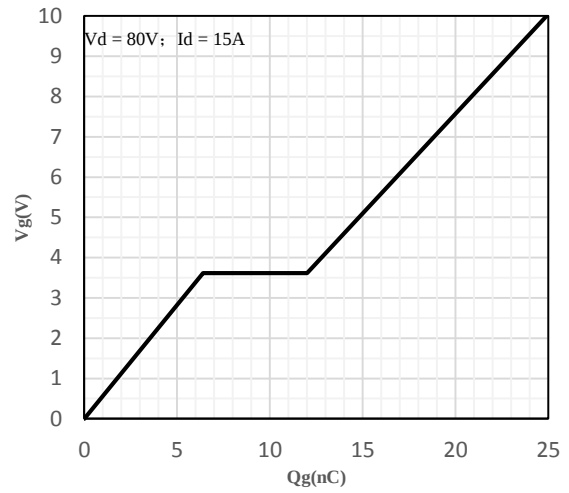


Fig 8 Gate-Charge Characteristics

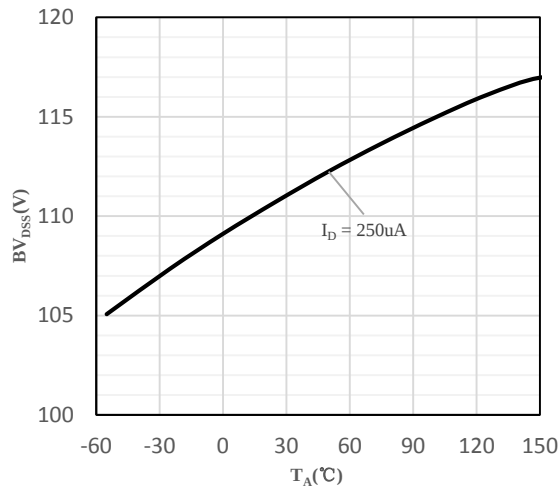


Figure 9 Normalized Breakdown Voltage
vs. Air Temperature

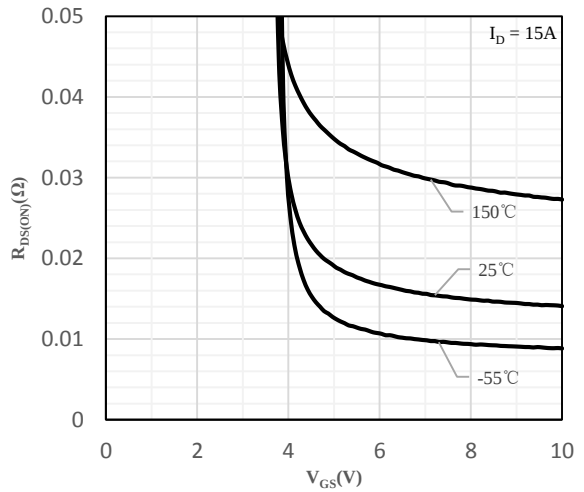


Figure 10 On-Resistance vs. Gate-Source Voltage

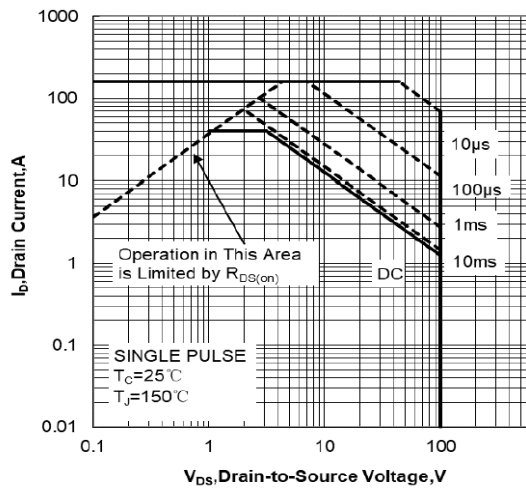
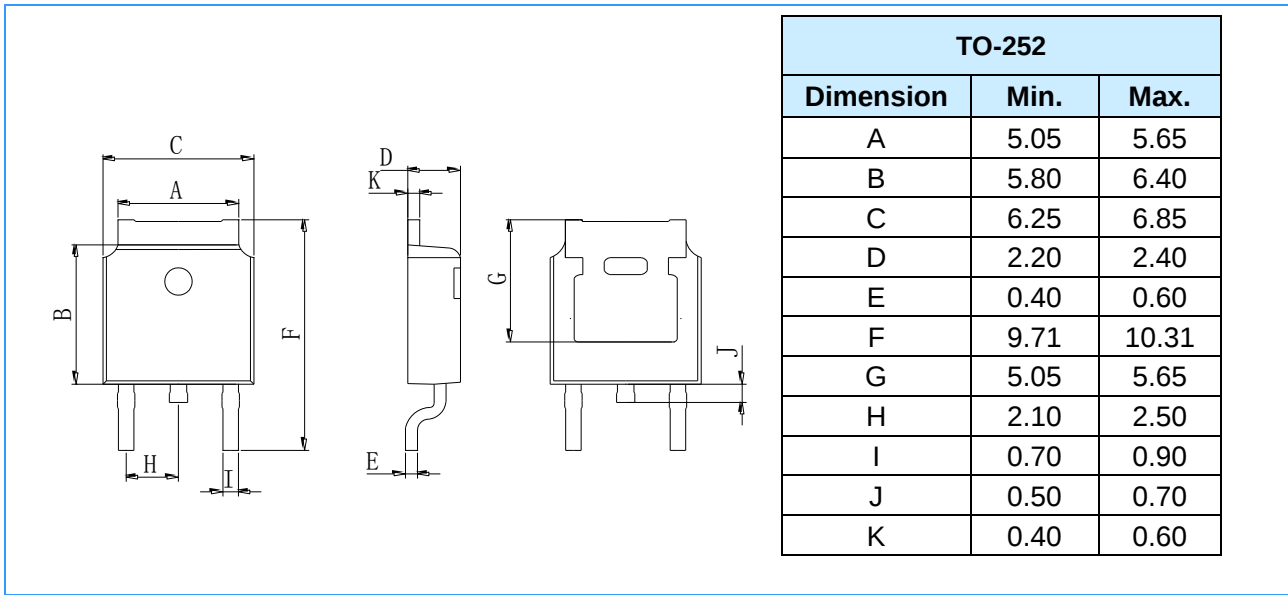
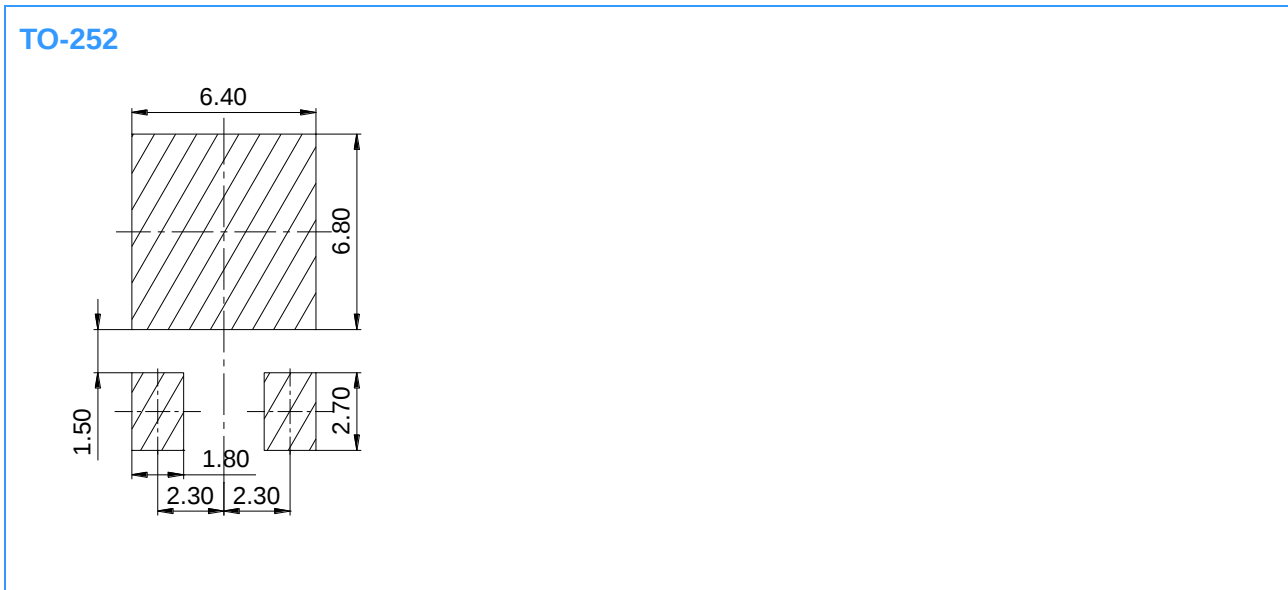


Fig 11 Maximum Safe Operating Area

Package Outline Dimensions (Unit: mm)



Mounting Pad Layout (Unit: mm)



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